

Notice of References Cited

Application/Control No.

10/775,888

Applicant(s)/Patent Under
Reexamination
ENDERMANN ET AL.

Examiner

Shengjun Wang

Art Unit

1617

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0024018	02-2004	Kanikanti et al.	514/312
	B	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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